# 2SD1275, 2SD1275A

## Silicon NPN triple diffusion planar type darlington

For power amplification

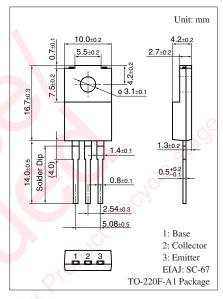
Complementary to 2SB0949 and 2SB0949A

### ■ Features

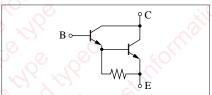
- High forward current transfer ratio h<sub>FE</sub>
- High-speed switching
- Full-pack package which can be installed to the heat sink with one screw

## ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage	2SD1275	V <sub>CBO</sub>	60	V
(Emitter open)	2SD1275A		80	
Collector-emitter voltage	2SD1275	V <sub>CEO</sub>	60	V
(Base open)	2SD1275A		80	
Emitter-base voltage (Coll	V <sub>EBO</sub>	5	V	
Collector current	$I_{C}$	2	A	
Peak collector current	$I_{CP}$	4	A	
Collector power	$T_C = 25^{\circ}C$	P <sub>C</sub>	35	W
dissipation			2.0	
Junction temperature	Tj	150	°C	
Storage temperature	T <sub>stg</sub>	-55 to +150	°C	



### Internal Connection



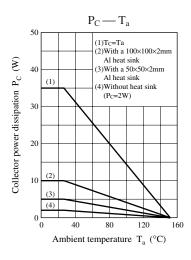
## ■ Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

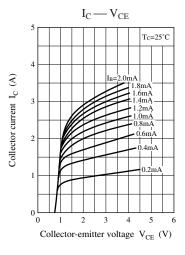
Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage	2SD1275	V <sub>CEO</sub>	$I_{\rm C} = 30 \text{ mA}, I_{\rm B} = 0$	60	· \ C	(J)	V
(Base open)	2SD1275A		11 00 inte co, me	80			
Base-emitter voltage		$V_{BE}$	$V_{CE} = 4 \text{ V}, I_{C} = 2 \text{ A}$	9.		2.8	V
Collector-base cutoff	2SD1275	$I_{CBO}$	$V_{CB} = 60 \text{ V}, I_{E} = 0$			1	mA
current (Emitter open)	2SD1275A	ř	$V_{CB} = 80 \text{ V}, I_{E} = 0$	0,		1	
Collector-emitter cutoff	2SD1275	$I_{CEO}$	$V_{CE} = 30 \text{ V}, I_{B} = 0$			2	mA
current (Base open)	2SD1275A		$V_{CE} = 40 \text{ V}, I_{B} = 0$			2	
Emitter-base cutoff current (Collector open)		$I_{EBO}$	$V_{EB} = 5 \text{ V}, I_C = 0$			2	mA
Forward current transfer ratio		$h_{FE1}$	$V_{CE} = 4 \text{ V}, I_{C} = 1 \text{ A}$	1 000			_
		h <sub>FE2</sub> *	$V_{CE} = 4 \text{ V}, I_{C} = 2 \text{ A}$	1 000		10 000	
Collector-emitter saturation voltage		V <sub>CE(sat)</sub>	$I_C = 2 \text{ A}, I_B = 8 \text{ mA}$			2.5	V
Transition frequency		$f_T$	$V_{CE} = 10 \text{ V}, I_{C} = 0.5 \text{ A}, f = 1 \text{ MHz}$		20		MHz
Turn-on time		t <sub>on</sub>	$I_C = 2 \text{ A}, I_{B1} = 8 \text{ mA}, I_{B2} = -8 \text{ mA},$		0.5		μs
Storage time		t <sub>stg</sub>	$V_{CC} = 50 \text{ V}$		4.0		μs
Fall time		t <sub>f</sub>			1.0		μs

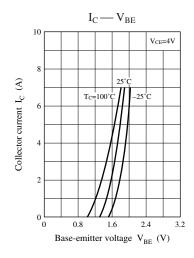
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

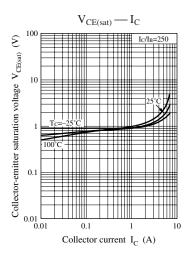
#### 2. \*: Rank classification

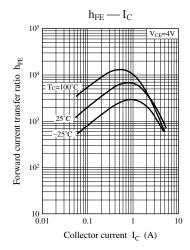
Rank	R	Q	Р	
$h_{\rm FE2}$	1000 to 2500	2000 to 5000	4000 to 10000	

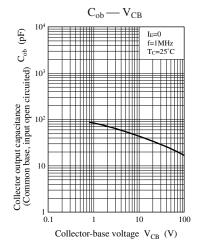


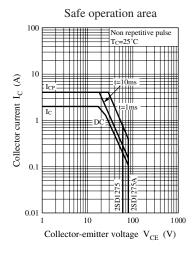


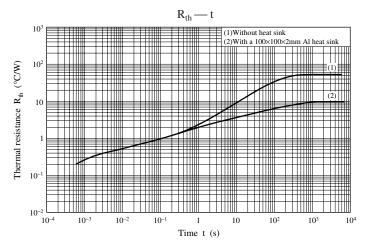












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